

DualPrecisionMonostable

General Description

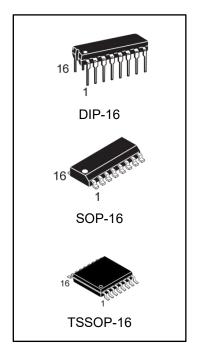
The CD4538B is a dual, precision monostable multivibrator with independent trigger and reset controls. The device is retriggerable and resettable, and the control inputs are inter- nally latched. Two trigger inputs are provided to allow either rising or falling edge triggering. The reset inputs are active low and prevent triggering while active. Precise control of output pulse-width has been achieved using linear CMOS techniques. The pulse duration and accuracy are deter-mined by external components Rx and Cx. The device does not allow the timing capacitor to discharge through the tim- ing pin on power-down condition. For this reason, no exter-nal protection resistor is required in series with the timing pin. Input protection from static discharge is provided on all pins.

Features

- Wide supply voltage range:5.0V to 15V
- High noise immunity:0.45 V_{CC} (typ.)
- Low power TTL compatibility:Fan out of 2 driving 74L or 1 driving 74LS
- New formula: PWout = RC (PW in seconds, R in Ohms, C in Farads)
- ±1.0% pulse-width variation from part to part (typ.)
- Wide pulse-width rang:1 µS to ∞
- Separate latched reset inputs
- Symmetrical output sink and source capability
- Low standby current:5 nA (typ.)@ 5 VDC
- Pin compatible to CD4528B

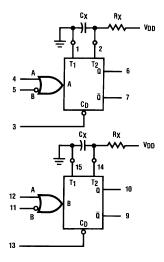
Ordering Information

DEVICE	Package Type	MARKING	Packing	Packing Qty
CD4538BE	DIP-16	CD4538B	TUBE	1000pcs/box
CD4538BM/TR	SOP-16	CD4538B	REEL	2500pcs/reel
CD4538BMT/TR	TSSOP-16	CD4538B	REEL	2500pcs/reel





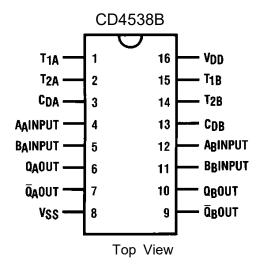
Block and Connection Diagrams



RX and CX are External Components $V_{\text{DD}} - \text{Pin 16}$

V_{SS}-Pin 8

Dual-In-Line Package



Truth Table

	Inputs	Out	puts	
Clear	Α	В	Q	Q
L	Х	Х	L	Н
X	Н	X	L	Н
X	X	L	L	Н
Н	L	↓	М	W
Н	↑	Н	M	W

H= High Level L

L= Low Level

↑= Transition from Low to High

↓= Transition from High to Low

M= One High Level Pulse

W= One Low Level Pulse

X= Irrelevant



Maximum Ratings

Symbol	Parameter	Min	Max	Unit			
VDD	DC Supply Voltage	DC Supply Voltage					
V _{IN}	Input Voltage	Input Voltage					
Ts	Storage Temperature Range	Storage Temperature Range					
P _D	Power Dissipation	Dual-In-Line	70	00	mW		
FD	Fower Dissipation	Small Outline	500		mW		
TL	Lead Temperature	Soldering, 10 seconds	26	30	$^{\circ}$		

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed, they are not meant to imply that the devices should be operated at these limits. The tables of "Recommended Operating Conditions" and "Electrical Characteristics" provide conditions for acutal device operation.

Note 2: VSS e 0V unless otherwise specified.

Recommended Operating Conditions

Symbol	Parameter	Min	Max	Unit
VDD	DC Supply Voltage	5	15	V_{DC}
V _{IN}	Input Voltage	0	-	V _{DC}
T _A	Operating Temperature Range	-40	+85	°C

DC Electrical Characteristics

Cumb al	Downwater	Conditions	-40)°C	+25°C			+85°C		
Symbol	Parameter	Conditions	Min	Max	Min	Тур	Max	Min	Max	Units
IDD	Quiescent Device Current	VDD=5V VDD=10V VDD=15V VIL=VSS VDD=15V All Outputs Open		20 40 80		0.005 0.010 0.015	20 40 80		150 300 600	μА
VOL	Low Level Output Voltage	VDD=5V VDD=10V VDD=15V VIH=VDD,ViL=Vss		0.05 0.05 0.05		0 0 0	0.05 0.05 0.05		0.05 0.05 0.05	V
VOH	High Level Output Voltage	VDD=5V VDD=10V VDD=15V VIH=VDD,ViL=Vss	4.95 9.95 14.95		4.95 9.95 14.95	5 10 15		4.95 9.95 14.95		V
VIL	Low Level Input Voltage	IIoI<1 μA VDD=5V,VO=0.5V of 4.5V VDD=10V,VO=1.0V of 9.0V VDD=15V,VO=1.5V of 13.5V		1.5 3.0 4.0		2.25 4.50 6.75	1.5 3.0 4.0		1.5 3.0 4.0	V
VIH	High Level Input Voltage	IIol<1 µA VDD=5V,VO=0.5V of 4.5V VDD=10V,VO=1.0V of 9.0V VDD=15V,VO=1.5V of 13.5V	3.5 7.0 11.0		3.5 7.0 11.0	2.75 5.50 8.25		3.5 7.0 11.0		V
IOL	Low Level Output Current (Note 3)	VDD=5V,VO 0.4V VDD=10V,VO=0.5V VDD=15V,VO=1.5V VIH=VDD VIL=VSS	0.52 1.3 3.6		0.44 1.1 3.0	0.88 2.25 8.8		0.36 0.9 2.4		mA
ЮН	High Level Output Current (Note 3)	VDD=5V,VO=4.6 VDD=10V,VO=9.5V VDD=15V,VO=13.5V	-0.52 -1.3 -3.6		-0.44 -1.1 -3.0	-0.88 -2.25 -8.8		-0.36 -0.9 -2.4		mA
IIN	Input Current, Pin2 or 14	VDD=15V, VIN=0V or 15V		±0.02		±10 ⁻⁵	±0.05		±0.5	μΑ
IIN	Input Current Other Inputs	VDD=15V, VIN=0V or 15V		±0.3		±10 ⁻⁵	±0.3		±1.0	μА

Note 3: IOH and IOL are tested one output at a time.



AC Electrical Characteristics

* TA = 25°C, C_L=50 pF, and tr= tf= 20 ns unless otherwise specified

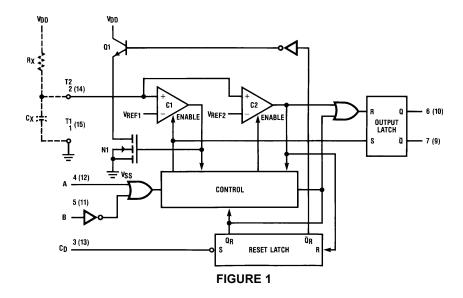
Symbol	Parameter	Condition	าร	Min	Тур	Max	Units
tTLH, tTHL	Output Transition Time	V_{DD} =5V V_{DD} =10V V_{DD} =15V			100 50 40	200 100 80	ns
tPLH, tPHL	Propagation Delay Time	Trigger Operation— A orB toQ orQ $V_{DD}=5V$ $V_{DD}=10V$ $V_{DD}=15V$ Reset Operation— C_D toQ orQ			300 150 100	600 300 220	ns
		$V_{DD}=5V$ $V_{DD}=10V$ $V_{DD}=15V$			250 125 95	500 250 190	ns
tWL, tWH	Minimum Input Pulse Width A, B, or C _D	V_{DD} =5V V_{DD} =10V V_{DD} =15V			35 30 25	70 60 50	ns
tRR	Minimum Retrigger Time	$V_{DD}=5V$ $V_{DD}=10V$ $V_{DD}=15V$			0	0 0 0	ns
CIN	Input Capacitance	Pin 2 or 14 Other Inputs			10 5	7.5	pF
		Rχ=100 kΩ	V_{DD} =5V V_{DD} =10V V_{DD} =15V	208 211 216	226 230 235	244 248 254	μS
PWOUT	Output Pulse Width (Q or Q) (Note : For Typical Distribution, see Figure 9)	Rχ=100 kΩ Cχ=0.1μF	V_{DD} =5 V V_{DD} =10 V V_{DD} =15 V	8.83 9.02 9.20	9.60 9.80 10.00	10.37 10.59 10.80	ms
		Rχ=100kΩ Cχ=10.0 μF	V_{DD} =5V V_{DD} =10V V_{DD} =15V	0.87 0.89 0.91	0.95 0.97 0.99	1.03 1.05 1.07	S
Pulse Width Match between Circuits in the Same Package Cχ=0.1 μF, Rχ=100 kΩ		Rχ=100 kΩ Cχ=0.1 μF	V_{DD} =5 V V_{DD} =10 V V_{DD} =15 V		±1 ±1 ±1		%
Operatir	ng Conditions				I		
RX CX	External Timing Resistance External Timing Capacitance			5.0 0		** No Limit	kΩ pF

Note 4:AC parameters are guaranteed by DC correlated testing.

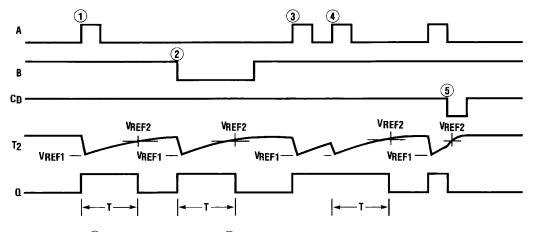
Note 5:The maximum usable resistance R_X is a function of the leakage of the Capacitor C_X , leakage of the CD4538B, and leakage due to board layout, surface resistance, etc.



Logic Diagram



Theory of Operation



- POSITIVE EDGE TRIGGER NEGATIVE EDGE TRIGGER
- POSITIVE EDGE RE-TRIGGER (PULSE LENGTHENING) RESET (PULSE SHORTENING)
- POSITIVE EDGE TRIGGER

FIGURE 2



Trigger Operation

The block diagram of the CD4538B is shown in Figure 1, with circuit operation following.

As shown in Figures 1 and 2, before an input trigger occurs, the monostable is in the quiescent state with the Q output low, and the timing capacitor C_X completely charged to V_{DD} . When the trigger input A goes from V_{SS} to V_{DD} (while inputs B and C_D are held to V_{DD}) a valid trigger is recog- nized, which turns on comparator C1 and N-Channel tran- sistor N1. At the same time the output latch is set. With transistor N1 on, the capacitor C_X rapidly discharges toward V_{SS} until V_{REF1} is reached. At this point the output of com- parator C1 changes state and transistor N1 turns off. Com- parator C1 then turns off while at the same time comparator C2 turns on. With transistor N1 off, the capacitor C_X begins to charge through the timing resistor, RX, toward V_{DD} . When the voltage across C_X equals V_{REF2} , comparator C2 changes state causing the output latch to reset (Q goes low) while at the same time disabling comparator C2. This ends the timing cycle with the monostable in the quiescent state, waiting for the next trigger.

A valid trigger is also recognized when trigger input B goes from V_{DD} to V_{SS} (while input A is at VSS and input CD is at V_{DD})².

It should be noted that in the quiescent state C_X is fully charged to V_{DD} , causing the current through resistor R_X to be zero. Both comparators are "off" with the total device current due only to reverse junction leakages. An added feature of the CD4538B is that the output latch is set via the input trigger without regard to the capacitor voltage. Thus, propagation delay from trigger to Q is independent of the value of C_X , R_X , or the duty cycle of the input waveform.

Retrigger Operation

The CD4538B is retriggered if a valid trigger occurs [®] fol lowed by another valid triggerm [®] before the Q output has returned to the quiescent (zero) state. Any retrigger, after the timing node voltage at pin 2 or 14 has begun to rise from VREF1, but has not yet reached VREF2, will cause an in crease in output pulse width T. When a valid retrigger is initiatedm[®], the voltage at T2 will again drop to VREF1 before progressing along the RC charging curve toward VDD. The Q output will remain high until time T, after the last valid retrigger.

Reset Operation

The CD4538B may be reset during the generation of the output pulse. In the reset mode of operation, an input pulse on CD sets the reset latch and causes the capacitor to be fast charged to VDD by turning on transistor Q1 $^{\odot}$. When the voltage on the capacitor reaches VREF2, the reset latch will clear and then be ready to accept another pulse. If the CD input is held low, any trigger inputs that occur will be inhibited and the Q and \overline{Q} outputs of the output latch will not change. Since the Q output is reset when an input low level is detected on the CD input, the output pulse T can be made significantly shorter than the minimum pulse width specification



Typical Applications

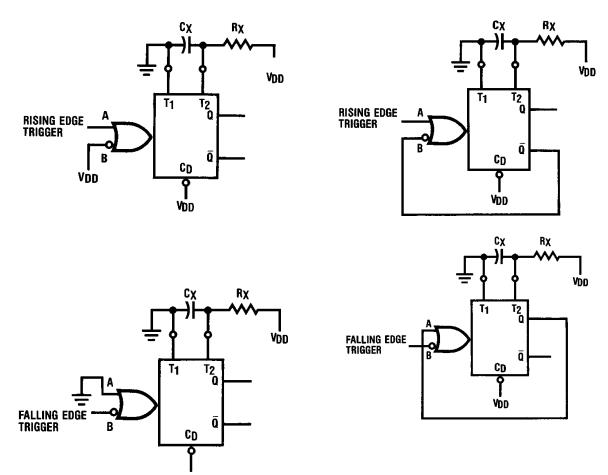


FIGURE 3. Retriggerable Monostables Circuitry

FIGURE 4. Non-Retriggerable Monostables Circuitry

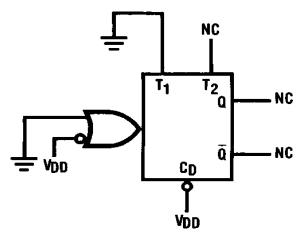


FIGURE 5. Connection of Unused Sections



Typical Applications

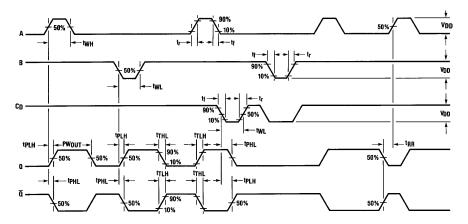
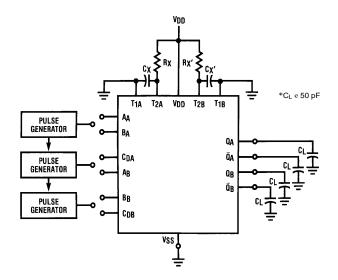
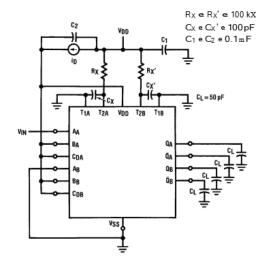


FIGURE 6. Switching Test Waveforms

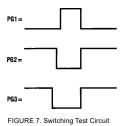




Input Connections

Characteristics	CD	Α	В
tPLH, tPHL, tTLH, tTHL PWOUT, tWH, tWL	V _{DD}	PG1	V _{DD}
tPLH, tPHL, tTLH, tTHL PWOUT, tWH, tWL	V _{DD}	V _{SS}	PG2
^t PLH(R), ^t PHL(R), ^t WH, ^t WL	PG3	PG1	PG2

*Includes capacitance of probes, wiring, and fixture parasitic Note: Switching test waveforms for PG1, PG2, PG3 are shown in Figure 6.



20 ns — — — — — — — — — — — — VDD — — — 0 V

Duty Cycle e 50%
FIGURE8.Power Dissipation Test

Circuit and Waveforms



Typical Applications

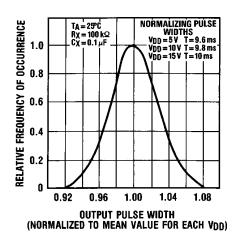


FIGURE 9. Typical Normalized Distribution of Units for Output Pulse Width

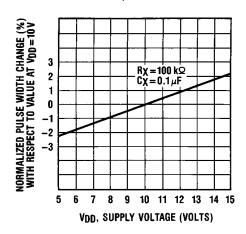


FIGURE 10. Typical Pulse Width Variation as a Function of Supply Voltage V_{DD}

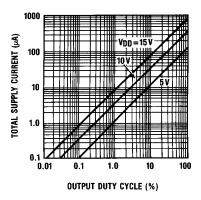


FIGURE 11. Typical Total Supply Current VersusFIGURE Output Duty Cycle, $R_X = 100 \text{ k}\Omega$, $C_L = 50 \text{ pF}$, $C_X = 100 \text{ pF}$, One Monostable Switching Only

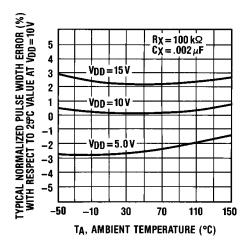


FIGURE 12. Typical Pulse Width Error Versus Temperature

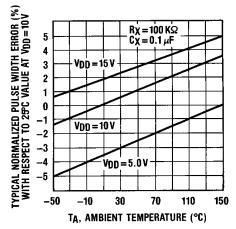


FIGURE 13. Typical Pulse Width Error Versus Temperature

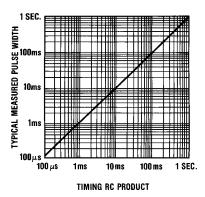
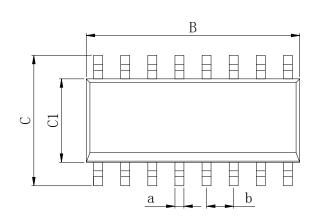


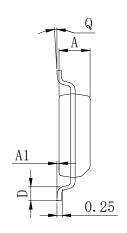
FIGURE 14. Typical Pulse Width Versus Timing RC Product



Physical Dimensions

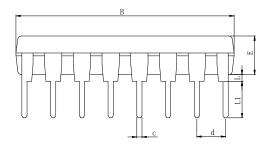
SOP16



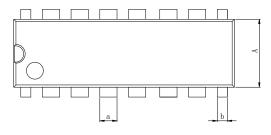


Dimensions In Millimeters(SOP16)											
Symbol:	Α	A1	В	С	C1	D	Q	а	b		
Min:	1.35	0.05	9.80	5.80	3.80	0.40	0°	0.35	1.27 BSC		
Max:	1.55	0.20	10.0	6.20	4.00	0.80	8°	0.45	1.27 BSC		

DIP16





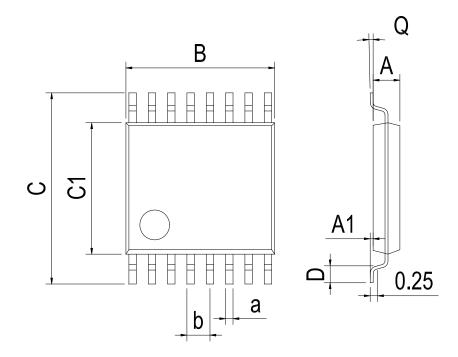


Dimensions In Millimeters(DIP16)											
Symbol:	Α	В	D	D1	E	L	L1	а	b	С	d
Min:	6.10	18.94	8.40	7.42	3.10	0.50	3.00	1.50	0.85	0.40	2.54 BSC
Max:	6.68	19.56	9.00	7.82	3.55	0.70	3.60	1.55	0.90	0.50	2.04 BSC



Physical Dimensions

TSSOP16



Dimensions In Millimeters(TSSOP16)											
Symbol:	Α	A1	В	С	C1	D	Q	а	b		
Min:	0.85	0.05	4.90	6.20	4.30	0.40	0°	0.20	0.65 BSC		
Max:	0.95	0.20	5.10	6.60	4.50	0.80	8°	0.25	0.05 BSC		



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